

<b>Notice of References Cited</b>	Application/Control No. 10/022,342	Applicant(s)/Patent Under Reexamination SHIBATA ET AL.	
	Examiner Katarzyna Wyrozebski Lee	Art Unit 1714	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,573,304	06-2003	Durand et al.	521/48
	C	US-3,907,868	09-1975	Currie et al.	560/98
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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